

Notice of References Cited

Application/Control No.

09/995,423

Applicant(s)/Patent Under
Reexamination
FANG, WEN-CHI

Examiner

Hai L. Nguyen

Art Unit

2816

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,263,448	07-2001	Tsern et al.	713/501
	B	US-5,565,816	10-1996	Coteus, Paul W.	331/2
	C	US-5,345,449	09-1994	Buckingham et al.	370/518
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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